EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	1252	348/222.1.ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/04/06 10:03
L2	888	382/284.ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/04/06 10:03
S17 6	0	"l63" and template	EPO	OR	OFF	2007/04/04 10:54
S17 7	20	"l63" and template	USPAT; EPO	OR	OFF	2007/04/04 10:54
S17 8	. 1	(US-6867882-\$).did.	USPAT	OR	OFF	2007/04/04 10:55
S17 9	1	(US-6867882-\$).did. and template	USPAT	OR	OFF	2007/04/04 10:55
S18 0	0	(US-6867882-\$).did. and (template with layout)	USPAT	OR	OFF	2007/04/04 10:55
S18	0	(US-6867882-\$).did. and (template same layout)	USPAT	OR .	OFF	2007/04/04 10:55
S18 2	1	(US-6867882-\$).did. and (template and layout)	USPAT	OR	OFF	2007/04/04 10:55
S18 3	1366	camera with template	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR .	ÓN	2007/04/05 13:12
S18 4	39	camera with template with paper	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/04/05 13:13

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S18 5	53	camera with template with mode	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON .	2007/04/05 13:14
S18 6	1366	camera with template	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/04/05 13:24
S18 7	25	camera with template with (button or knob or switch)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR .	ON	2007/04/05 13:24
S18 8	26	camera with template with (button or knob or switch or keypad)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/04/05 13:40
S18 9	130	camera with (template or layout) with (button or knob or switch or keypad)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/04/05 13:53
S19 0	140	camera with (template or layout) with (button or knob or switch or keypad or menu)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/04/05 13:53



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IEEE CNF	IEEE Conference Proceeding			Multiview Image Acquis Son, JY.; Saveljev, V. V Display Technology, Jou	'.; Kim, JS.; Kwa		.;
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